

深圳市川晶实业有限公司

产品规格承认书

SPECIFICATION FOR APPROVAL

客户名称: _____ 客户料号: _____
产品名称: 石英晶体谐振器 产品类别: 电子
产品型号: SMD 2520 产品频率: 24.000MHz
川晶料号: 2520.24000.003 制作日期: 2022年1月4日

客户确认		客户确认签章
确认人		
部 门		
日 期		

◇请客户确认签章一份产品规格承认书做副本。

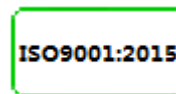
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制 作	审 核	批 准	签 章
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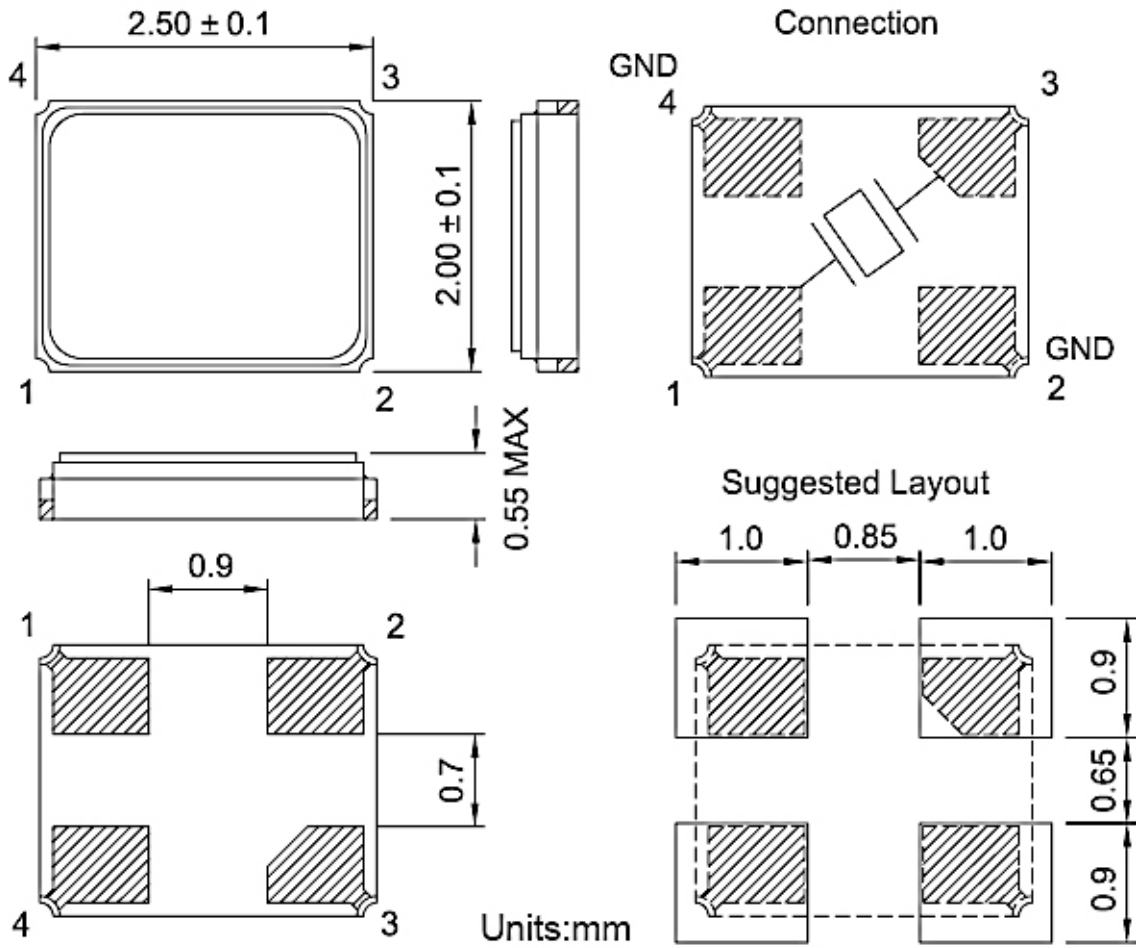
GENERAL SPECIFICATIONS (电气特性):

1.Holder type: (型号)	2520/SMD	
2.Normal Frequency: (标称频率)	24.000 MHz	
3.Oscillation Mode: (振动模式)	AT-Fundamental	
4.Load Capacitance(CL): (负载电容)	12 PF	
5.Frequency Tolerance 25±3°C: (频率偏差 25±3°C)	± 10 PPM	
6.Effective Series Resistance: (等效电阻)	≤ 60 Ω	
7.DLD2 (不同功率下之最大与最小阻抗差值)	≤ 7 Ω	0.01 uW~100 uW 10 steps
8.RLD2 (不同功率下之最大阻抗值)	≤ 25 Ω	0.01 uW~100 uW 10 steps
9.FDLL (不同功率下之最大与最小 FR 差值)	≤ 8 PPM	0.01 uW~100 uW 10 steps
10.Shunt Capacitance(C0): (静态电容)	≤ 7 PF	
11. Typical drive level: (激励功率)	100 uW TYP.	
12.Operation Temperature Range: (工作温度范围)	-20°C to +70°C	
13.Stability Over Temperature Range: (工作温度频率偏差)	±10 PPM at -40°C to+85°C	
14.Insulation Resistance: (绝缘阻抗)	≥500 MΩ at DC 100V	
15.Aging: (老化率)	±5 PPM/Year	
16.Storage Temperature: (存储温度)	-40°C to +85°C	
17.Test circuit (测试仪器)	S&A 250B Pi-Network Crystal Measurement System	

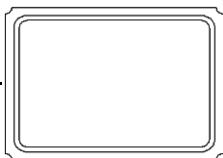
Remark (备注):

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DIMENSIONS SPECIFICATIONS (外形尺寸)



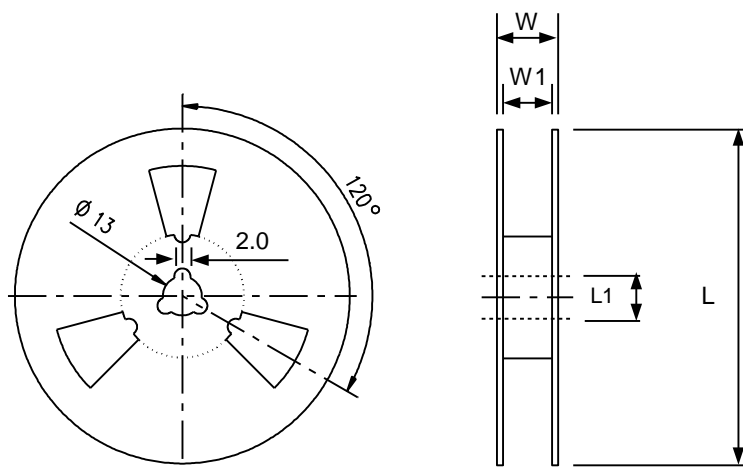
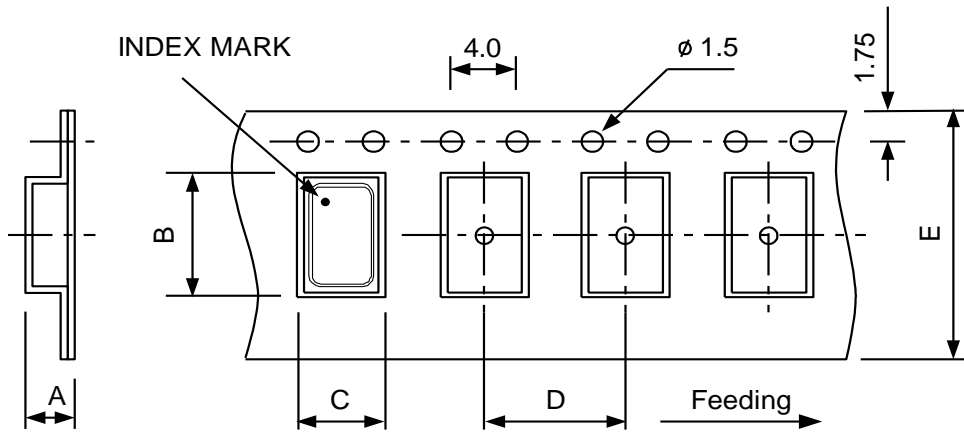
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PACKING (包装)

Shear strength between cover and carrier tape should be 30-100g.
Carrier tape should be folded over three times with no break at all.



DIMENSIONS		A	B	C	D	E	L	L1	W	W1
	7050	2.15	7.9	5.4	8	16	180	13	21.5	17.5
	6035	1.5	6.4	3.9	8	12	180	13	15.4	13
	5032	1.5	5.5	3.6	8	12	180	13	15.4	13
	4025	1.5	4.4	2.8	8	12	180	13	15.4	13
	3225	1.4	3.4	2.7	4	8	180	13	11.5	8
2520	1.2	3.2	2.8	3.5	8	180	13	11.5	8	

Unit : mm

Standard Reel Quantity is 3000 pcs per reel.

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RELIABILITY SPECIFICATIONS 可靠性测试标准

NO.	ITEMS 项目	CONDITIONS 条件	SPECIFICATIO N 规格	
1	Lead Bend 端子强度	a) Pulling: According to experiment of IEC 68-2-21 Ua1 experiment, pull 10N. a) 拉力: 按IEC 68-2-21中试验Ua1进行, 拉力10N。	B	
		b) Bending: According to experiment of IEC 68-2-21 method Ub. Add the burthen of 5N to lead, and 2.5±0.5mm refer to the base for 3 times. b) 弯曲强度: 按IEC 68-2-21中试验Ub进行, 负荷应限制在距晶体元件本体2.5±0.5mm处开始弯曲, 所加质量负荷为5N, 弯曲次数为3次。		
2	Solderability 可焊性	According to experiment of IEC 68-2-20 Ta method 1, Solder temperature is 235°C. 按IEC 68-2-20中试验Ta的方法1进行, 焊接温度235°C。	C	
		According to experiment of IEC 68-2-20 method Tb 1A: solder slit method. Solder temperature: 260±5°C, dip time 10±1s. 按IEC 68-2-20试验Tb方法1A: 焊锡槽方法进行。 焊接温度: 260±5°C, 浸入时间: 10±1秒。		
3	Solder heat resistance 耐焊接热	According to experiment of 68-2-6 method Fc, The entire frequency range, from 10Hz to 55Hz and return to 10Hz, and shall be transferred in 1 min. Amplitude (total excursion): 1.5mm Duration=2 hours for each of the main axes (x, y, z). 按IEC 68-2-6试验Fc进行, 振动频率在1分钟内从10~55Hz, 再回到10Hz, 振幅1.5mm, X、Y、Z三个方向各2小时。	A	
		According to experiment of IEC 68-2-27 method Ea, the biggest acceleration : 981m/s ² (100g), work time : 6ms, and 6 surfaces, and 3 directions for each surface, and shall be Shocked 18 times in total. 按IEC 68-2-27试验Ea进行, 最大加速度: 981m/s ² (100g), 作用时间: 6ms, 6面, 每面三个方向, 共18次。		
4	Vibration 耐振性	According to experiment of IEC 68-2-1 method Aa, The quartz crystal unit should be stored at a temperature -40±3°C for 2 hours, and then it shall be subjected to standard atmospheric conditions for 1 hour, after which measurement shall be made. 按IEC 68-2-1试验Aa进行, 晶体在温度-40±3°C中放置2小时后, 在常温常湿状态下放置1小时后测试。	A	
		According to experiment of IEC 68-2-2 Ba, quartz crystal unit should be stored at a temperature 85±2°C for 2 hours. Then it shall be subjected to standard atmospheric conditions for 1 hour, after which measurement shall be made. 按IEC 68-2-2试验Ba进行, 晶体在温度85±2°C中放置2小时后, 在常温常湿状态下放置1小时后测试。		
5	Shock 耐冲击性	According to experiment of IEC 68-2-3 method Ta, quartz crystal unit should be stored at a temperature 40±2°C and at humidity 90~95% for 96 hours. Then it shall be subjected to standard atmospheric conditions for 1 hour. 按IEC 68-2-3试验Ta进行, 晶体在温度40±2°C, 湿度90~95%中放置96小时后, 在常温常湿状态下放置1小时后测试。	AB	
		According to experiment of IEC 68-2-14 method Na, quartz crystal unit shall be made 5 temperature cycles, and then it shall be subjected to standard atmospheric conditions for 1 hour. 按IEC 68-2-14试验Na进行, 晶体按下表做5个温度循环后, 在常温常湿状态下放置1小时后测试。		
6	Dry Heat 干热	According to experiment of IEC 68-2-3 method Ta, quartz crystal unit should be stored at a temperature 40±2°C and at humidity 90~95% for 96 hours. Then it shall be subjected to standard atmospheric conditions for 1 hour. 按IEC 68-2-3试验Ta进行, 晶体在温度40±2°C, 湿度90~95%中放置96小时后, 在常温常湿状态下放置1小时后测试。	A	
		According to experiment of IEC 68-2-3 method Ta, quartz crystal unit should be stored at a temperature 40±2°C and at humidity 90~95% for 96 hours. Then it shall be subjected to standard atmospheric conditions for 1 hour. 按IEC 68-2-3试验Ta进行, 晶体在温度40±2°C, 湿度90~95%中放置96小时后, 在常温常湿状态下放置1小时后测试。		
7	High heat and high humidity 稳 态湿热	According to experiment of IEC 68-2-14 method Na, quartz crystal unit shall be made 5 temperature cycles, and then it shall be subjected to standard atmospheric conditions for 1 hour. 按IEC 68-2-14试验Na进行, 晶体按下表做5个温度循环后, 在常温常湿状态下放置1小时后测试。	A	
		According to experiment of IEC 68-2-14 method Na, quartz crystal unit shall be made 5 temperature cycles, and then it shall be subjected to standard atmospheric conditions for 1 hour. 按IEC 68-2-14试验Na进行, 晶体按下表做5个温度循环后, 在常温常湿状态下放置1小时后测试。		
8	Temperature Cycling 温度 变化	TEMPERATURE 温度	STORE TIME 放置时间	
		1	-40±3°C	30min
		2	Normal Temp(常温)	30sec
		3	100±2°C	30min
		4	Normal Temp(常温)	30sec

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10	Drop 跌落	According to experiment of IEC 68-2-32 method Ed, quartz crystal unit shall be dropped from 75cm height on 3cm hard board for 3 times.	AB
		按IEC 68-2-32试验Ed进行，晶体从75厘米高度自由下落至3厘米硬木板，重复3次。	
11	Reflow 回流焊	Reflow soldering cure see the chart.	A
		回流焊曲线见下图。 	
12	Leakage 气密性	Alcohol press method: quartz crystal unit shall be immersed in the can, and pressed by 0.5kg press for 30min; Then put away press, and dry it. Quartz crystal unit shall be test insulation resistance by 100V volts d.c for 1 min.	D
		酒精加压法：晶体浸入酒精罐中，加压（压力0.5kg，时间30分钟）；撤去压力后，晾干晶体，测量引线与外壳之间绝缘电阻（100V直流电压，时间1分钟）。	
13	Aging 老化	Quartz crystal unit shall be stored at a temperature $85\pm 2^{\circ}\text{C}$ for 720 ± 12 hours(30days), and then it shall be subjected to standard atmospheric conditions for 1 hour.	A
		晶体在温度 $85\pm 2^{\circ}\text{C}$ 中放置720小时（30天） ± 12 小时后，在常温常湿状态下放置1小时后测试。	

Accept Level:
判定标准:

No.	specification 标准
A	Satisfying the electric characteristic; Frequency change is at the range of 5PPM and resistance change is at the range of 5Ω . 电气性能可满足要求：频率变化量在5ppm以内,电阻变化量在 5Ω 以内。
B	After each test, no visible damage shall be manifested, nor shall the hermetic seal break down 试验后，无机械损伤
C	Dipping in 3 sec. A new uniform coating of solder shall cover a minimum of 95% of the surface being immersed. 浸锡时间3秒以内，引线挂锡面积95%以上。
D	Insulation resistance of leads shall be more than $500\text{M}\Omega(100\text{V DC})$. 端子之间的绝缘电阻 $\geq 500\text{M}\Omega(100\text{V DC})$ 。